

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/551,645	OTSUKA ET AL.	
				Examiner	Art Unit	
				Aaron N. Wilson	3747	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
123	193.6	3/20/2007	AW	EAST text search (See attached list)	3/20/2007	AW
123	193.4	3/20/2007	AW		1/2/08	HHH
123	41.34	1/2/08	HHH			
123	41.35	1/2/08	HHH			
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			